

**A1MNK2P0**

Pb RoHS

80V N-Channel MOSFETs**General Description**

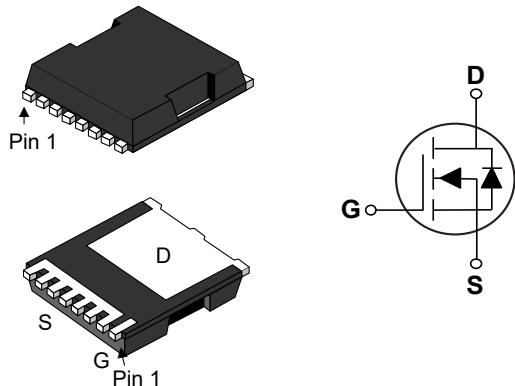
These N-Channel enhancement mode power field effect transistors are using trench MOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

BV_{DSS}	R_{DS(ON)}	I_D
80 V	2 mΩ	310 A

Features

- R_{DS(ON)} ≤ 2mΩ @ V_{GS} = 10V
- Fast Switching
- Improved dv/dt Capability
- Green Device Available

TOLLA-8 Pin Configuration

**Applications**

- DC/DC Converter
- Power Management Switching
- Motor Driver

Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	80	V
V _{GS}	Gate-Source Voltage	±20	V
I _D	Drain Current - Continuous (T _C =25°C)	310	A
I _{DM}	Drain Current - Pulsed (NOTE 1)	1240	A
EAS	Single Pulse Avalanche Energy (NOTE 2)	625	mJ
P _D	Power Dissipation (T _C =25°C)	347.2	W
T _{STG}	Storage Temperature Range	-55 to 150	°C
Marking Code		NK2P0	

Thermal Characteristics

Symbol	Parameter	Rating	Unit
R _{θJA}	Thermal Resistance Junction to Ambient	40	°C/W
R _{θJC}	Thermal Resistance Junction to Case	0.36	°C/W



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Electrical Characteristics ($T_J=25^\circ\text{C}$, unless otherwise noted)

Off Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}$, $I_D=250\mu\text{A}$	80	---	---	V
I_{DSS}	Drain-Source Leakage Current	$V_{\text{DS}}=80\text{V}$, $V_{\text{GS}}=0\text{V}$	---	---	1	μA
I_{GSS}	Gate-Source Leakage Current	$V_{\text{GS}}=\pm 20\text{V}$, $V_{\text{DS}}=0\text{V}$	---	---	± 100	nA

On Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$R_{\text{DS}(\text{ON})}$	Static Drain-Source On-Resistance	$V_{\text{GS}}=10\text{V}$, $I_D=20\text{A}$	---	---	2	$\text{m}\Omega$
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$V_{\text{GS}}=V_{\text{DS}}$, $I_D=250\mu\text{A}$	2.0	---	4.0	V
g_{fs}	Forward Transconductance	$V_{\text{DS}}=10\text{V}$, $I_D=20\text{A}$	---	70	---	S

Dynamic and switching Characteristics (NOTE 4)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
Q_g	Total Gate Charge	$V_{\text{DS}}=40\text{V}$, $V_{\text{GS}}=10\text{V}$, $I_D=20\text{A}$	---	140	---	nC
Q_{gs}	Gate-Source Charge		---	37.5	---	
Q_{gd}	Gate-Drain Charge		---	37.5	---	
$T_{\text{d}(\text{on})}$	Turn-On Delay Time	$V_{\text{DD}}=40\text{V}$, $V_{\text{GS}}=10\text{V}$, $R_G=3\Omega$, $I_D=20\text{A}$	---	27.5	---	nS
T_r	Rise Time		---	82	---	
$T_{\text{d}(\text{off})}$	Turn-Off Delay Time		---	85	---	
T_f	Fall Time		---	52	---	
C_{iss}	Input Capacitance	$V_{\text{DS}}=40\text{V}$, $V_{\text{GS}}=0\text{V}$, $F=1\text{MHz}$	---	8980	---	pF
C_{oss}	Output Capacitance		---	1560	---	
C_{rss}	Reverse Transfer Capacitance		---	90	---	
R_g	Gate Resistance	$V_{\text{GS}}=0\text{V}$, $V_{\text{DS}}=0\text{V}$, $F=1\text{MHz}$	---	2.4	---	Ω

Drain-Source Diode Characteristics and Ratings

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
I_s	Continuous Source Current	$V_G=V_D=0\text{V}$, Force Current	---	---	310	A
V_{SD}	Diode Forward Voltage	$V_{\text{GS}}=0\text{V}$, $I_s=20\text{A}$	---	---	1.2	V

NOTES :

- Repetitive Rating : Pulsed width limited by maximum junction temperature.
- The EAS data shows Max. rating. The test condition is $V_{\text{DD}}=25\text{V}$, $V_{\text{GS}}=10\text{V}$, $L=0.5\text{mH}$, $I_{\text{AS}}=50\text{A}$.
- The data tested by pulsed, pulse width $\leq 300\text{us}$, duty cycle $\leq 2\%$.
- Guaranteed by design, not subject to production testing.



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Characteristics Curves

FIG. 1-Transfer Characteristics

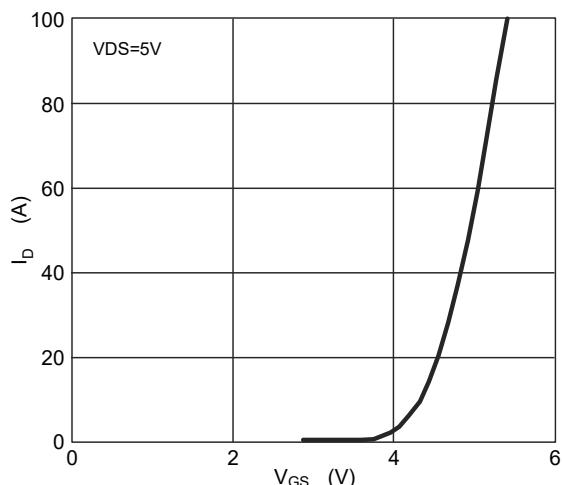


FIG. 3- $R_{DS(on)}$ vs I_D

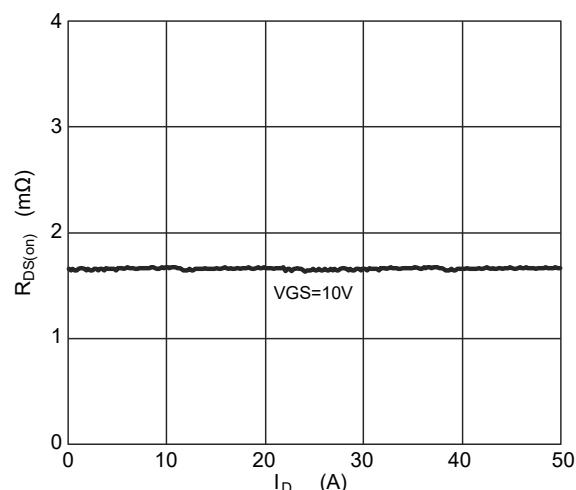


FIG. 5-Gate Charge Characteristics

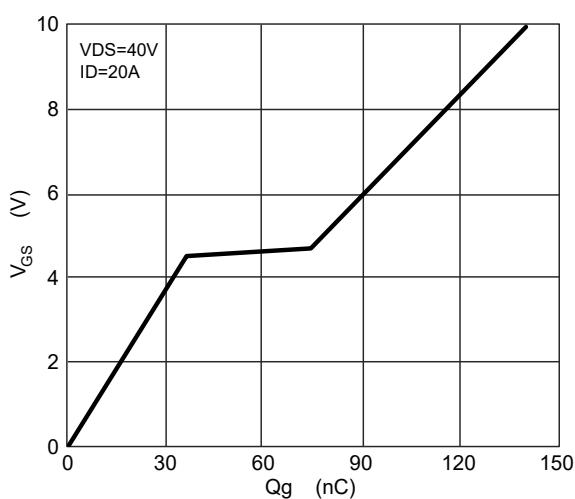


FIG. 2- I_S vs V_{SD}

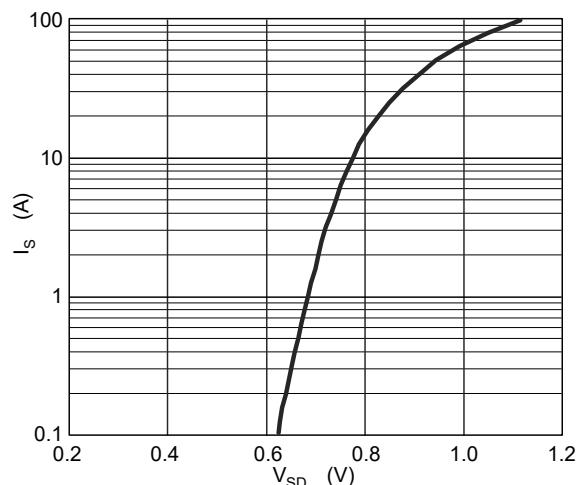


FIG. 4-Normalized $R_{DS(on)}$ vs T_J

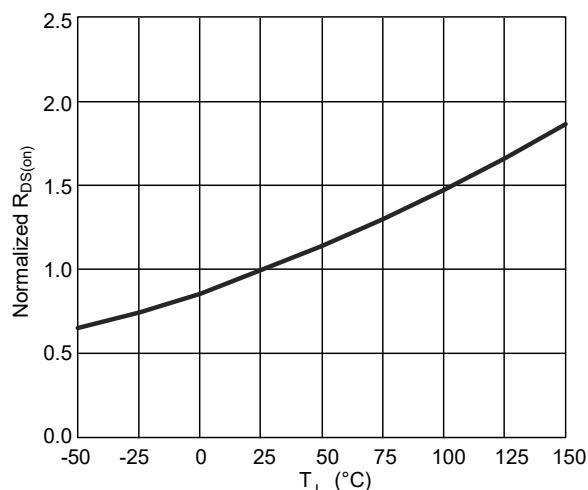
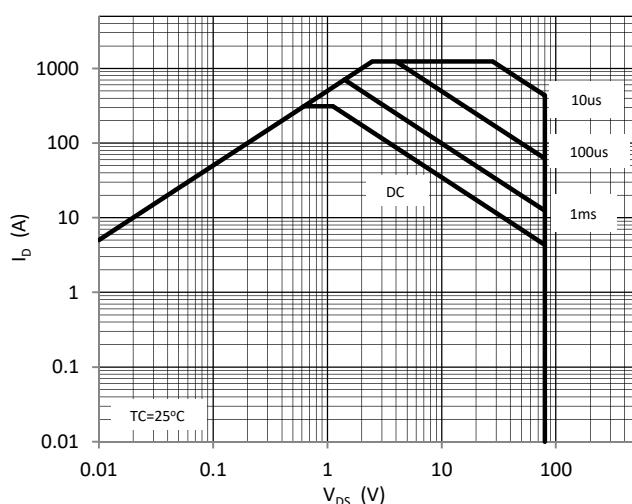


FIG. 6-Safe Operating Area





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Characteristics Curves

FIG. 7-Transient Thermal Impedance

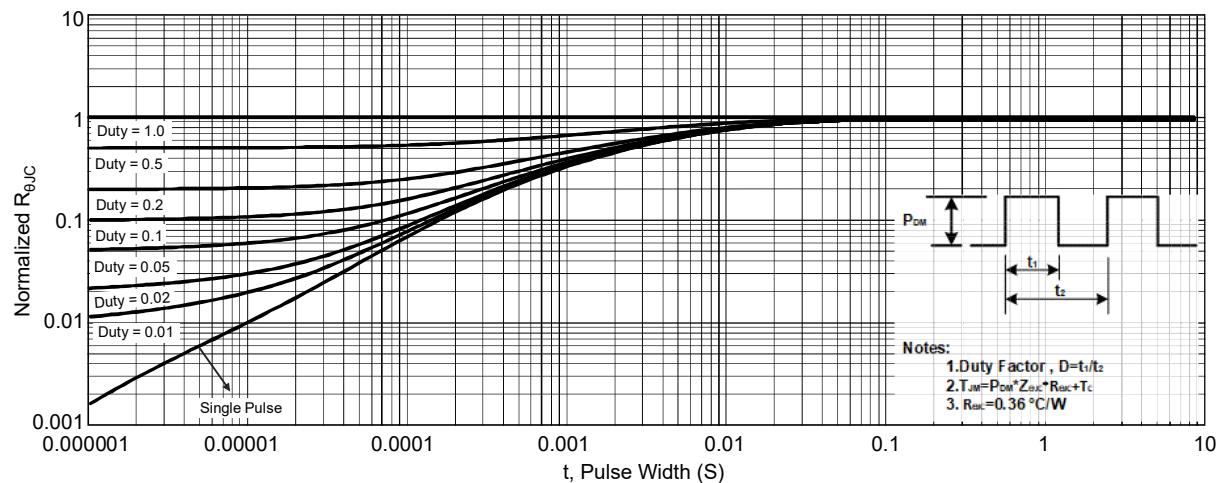


FIG. 8-Power Dissipation

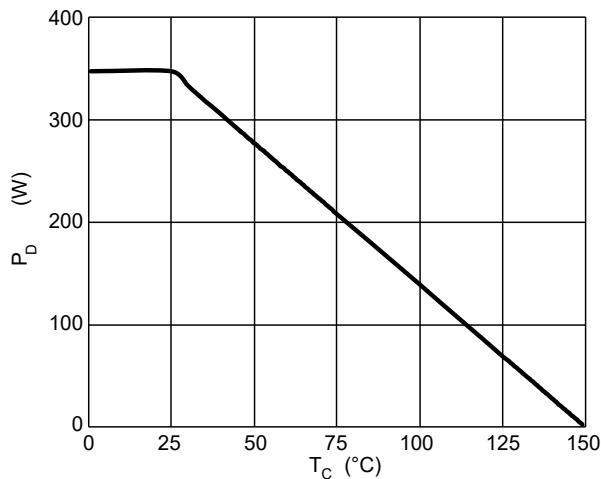
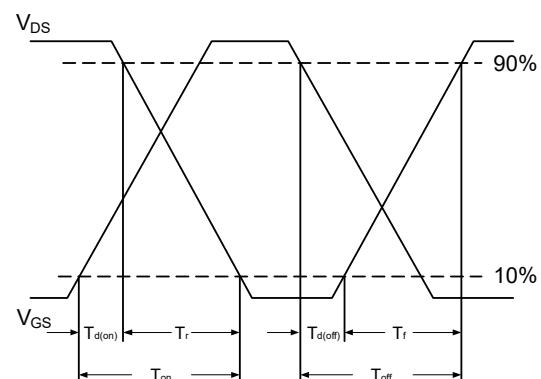


FIG. 9-Switching Time Waveform



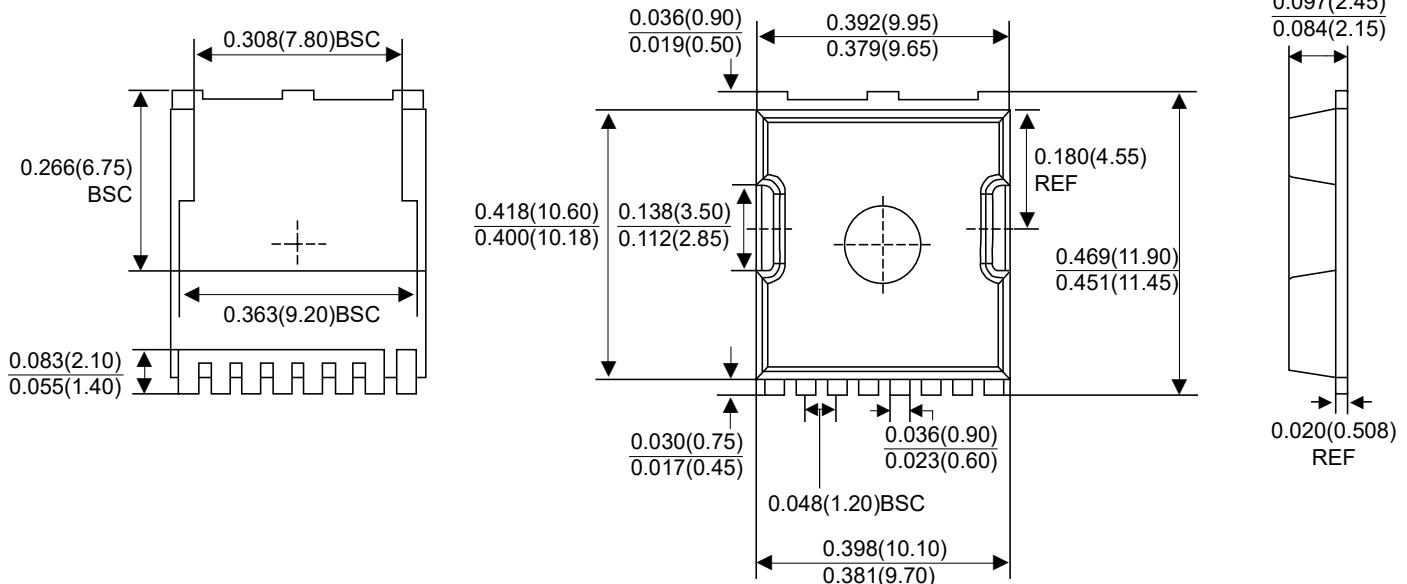
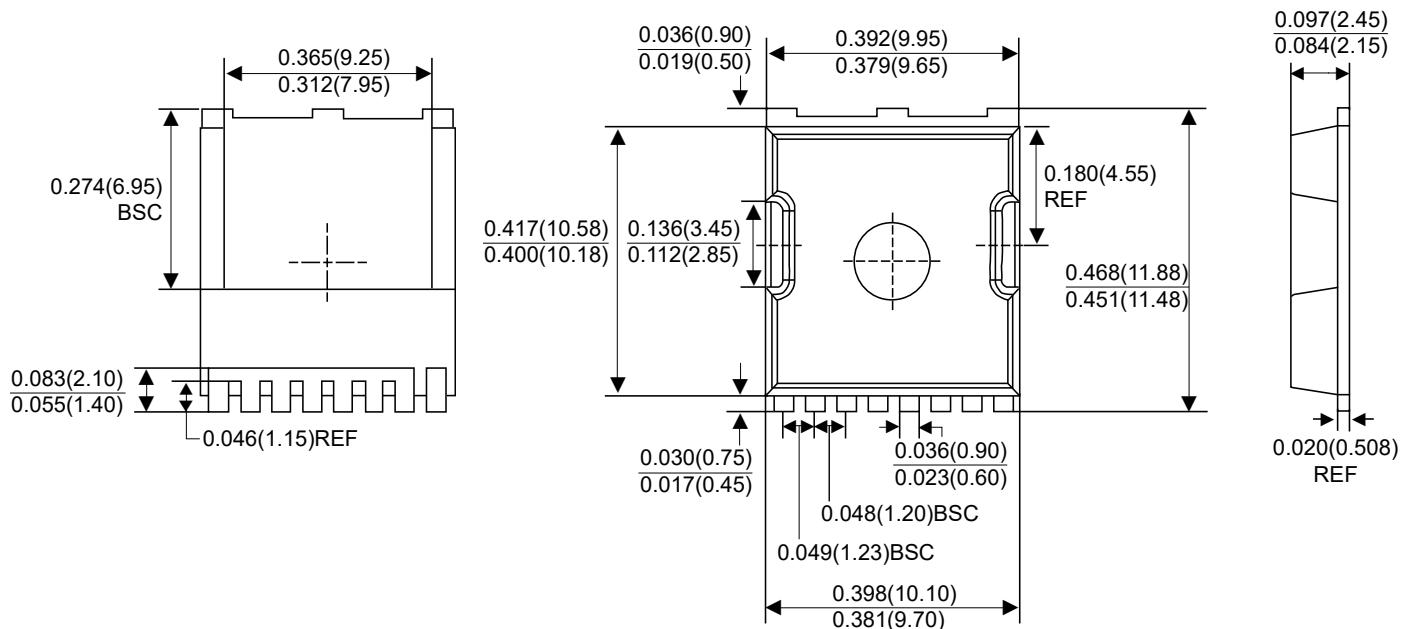


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Package Outline Dimensions



TOLLA-8

Dimensions in inches and (millimeters)



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